

10575775_CLSTI TLES

Titles of most frequently occurring classifications of patents returned from a search of 10575775 on Feb 26 , 2009

- 6 353/ 122 (2 OR, 4 XR)
Class 353 OPTI CS: I MAGE PROJECTORS
353/ 122 . M SCELLANEOUS
- 6 353/ 28 (4 OR, 2 XR)
Class 353 OPTI CS: I MAGE PROJECTORS
353/ 28 . PROJECTED I MAGE COMBINED WITH REAL OBJECT
- 5 356/ 622 (0 OR, 5 XR)
Class 356 OPTI CS: MEASURING AND TESTING
356/ 614 . POSI TI ON OR DI SPLACEMENT
356/ 615 .. Position transverse to viewing axis
356/ 622 ... Position of detected arrangement relative to projected
beam
- 3 378/ 8 (0 OR, 3 XR)
Class 378 X- RAY OR GAMMA RAY SYSTEMS OR DEVI CES
378/ 1 . SPECI FI C APPLI CATI ON
378/ 4 .. Computerized tomography
378/ 8 ... Object responsive
- 3 250/ 559. 06 (1 OR, 2 XR)
Class 250 RADI ANT ENERGY
250/ 200 . PHOTOCELLS; CI RCUI TS AND APPARATUS
250/ 559. 01 .. With circuit for evaluating a web, strand, strip, or sheet
250/ 559. 04 ... Evaluation by regions, zones, or pixels
250/ 559. 06 With scanning
- 3 250/ 559. 24 (0 OR, 3 XR)
Class 250 RADI ANT ENERGY
250/ 200 . PHOTOCELLS; CI RCUI TS AND APPARATUS
250/ 559. 01 .. With circuit for evaluating a web, strand, strip, or sheet
250/ 559. 19 ... Measuring dimensions
250/ 559. 24 Transversal measurement (e. g. , wi dth, di amet er,
cross- sect i onal area)
- 2 382/ 118 (1 OR, 1 XR)
Class 382 I MAGE ANALYSI S
382/ 100 . APPLI CATI ONS
382/ 115 .. Personnel identification (e. g. , bi ometri cs)
382/ 118 ... Using a faci al characteri stic
- 2 382/ 206 (0 OR, 2 XR)
Class 382 I MAGE ANALYSI S
382/ 181 . PATTERN RECOGNI TI ON
382/ 190 .. Feature extraction
382/ 206 ... Gl obal features (e. g. , measurements on i mage as a whol e,
such as area, projections, etc.)
- 2 382/ 203 (0 OR, 2 XR)
Class 382 I MAGE ANALYSI S
382/ 181 . PATTERN RECOGNI TI ON
382/ 190 .. Feature extraction
382/ 195 ... Local or regional features
382/ 203 Shape and form analysi s
- 2 382/ 291 (0 OR, 2 XR)
Class 382 I MAGE ANALYSI S
382/ 276 . I MAGE TRANSFORMATI ON OR PREPROCESSI NG

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382/ 286 .. Measuring image properties (e.g., length, width, or area)
382/ 291 ... Determining the position of an object

2 356/ 394 (2 OR, 0 XR)
Class 356 OPTI CS: MEASURI NG AND TESTI NG
356/ 388 .. BY CONFI GURATI ON COMPARI SON
356/ 394 .. With comparison to master, desired shape, or reference
voltage

2 382/ 218 (0 OR, 2 XR)
Class 382 I MAGE ANALYSI S
382/ 181 .. PATTER N RECOGNI TI ON
382/ 209 .. Templ ate matching (e.g., specific devices that determine
the best match)
382/ 217 ... El ectroni c templ ate
382/ 218 Compar at or

2 378/ 16 (2 OR, 0 XR)
Class 378 X- RAY OR GAMMA RAY SYSTEMS OR DEVI CES
378/ 1 .. SPECI FI C APPLI CATI ON
378/ 4 .. Comput erized tomogr aphy
378/ 16 ... Beam energy or intensity control

2 378/ 108 (0 OR, 2 XR)
Class 378 X- RAY OR GAMMA RAY SYSTEMS OR DEVI CES
378/ 91 .. ELECTRONI C CI RCUI T
378/ 101 .. X-ray source power supply
378/ 108 ... Dose regul ated

2 178/ 18.09 (1 OR, 1 XR)
Class 178 TELEGRAPHY
178/ 2R .. SYSTEMS
178/ 18.01 .. Position coordinate determination for writing (e.g.,
writing digitizer pad, stylus, or circuitry)
178/ 18.03 ... Witing digitizer pad
178/ 18.09 Opti cal

2 345/ 179 (1 OR, 1 XR)
Class 345 COMPUTER GRAPHI CS PROCESSI NG AND SELECTI VE VI SUAL DI SPLAY
SYSTEMS
345/ 156 .. DI SPLAY PERI PHERAL I NTERFACE I NPUT DEVI CE
345/ 179 .. Styl us

2 382/ 287 (1 OR, 1 XR)
Class 382 I MAGE ANALYSI S
382/ 276 .. I MAGE TRANSFORMATI ON OR PREPROCESSI NG
382/ 286 .. Measuring image properties (e.g., length, width, or area)
382/ 287 ... Detecting alignment marks

2 382/ 282 (1 OR, 1 XR)
Class 382 I MAGE ANALYSI S
382/ 276 .. I MAGE TRANSFORMATI ON OR PREPROCESSI NG
382/ 282 .. Selecting a portion of an image

2 382/ 199 (0 OR, 2 XR)
Class 382 I MAGE ANALYSI S
382/ 181 .. PATTER N RECOGNI TI ON
382/ 190 .. Feature extraction
382/ 195 ... Local or regional features
382/ 199 Pattern boundary and edge measurements

2 250/ 559.22 (0 OR, 2 XR)
Class 250 RADI ANT ENERGY

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250/ 200 . PHOTOCELLS; CIRCUITS AND APPARATUS
250/ 559. 01 .. With circuit for evaluating a web, strand, strip, or sheet
250/ 559. 19 ... Measuring dimensions
250/ 559. 22 Profile

2 382/ 217 (0 OR, 2 XR)
Class 382 IMAGE ANALYSIS
382/ 181 . PATTERN RECOGNITION
382/ 209 .. Template matching (e.g., specific devices that determine
the best match)
382/ 217 ... Electronic template

2 250/ 234 (2 OR, 0 XR)
Class 250 RADIANT ENERGY
250/ 200 . PHOTOCELLS; CIRCUITS AND APPARATUS
250/ 216 .. Optical or pre-photocell system
250/ 234 ... Means for moving optical system

2 250/ 559. 19 (0 OR, 2 XR)
Class 250 RADIANT ENERGY
250/ 200 . PHOTOCELLS; CIRCUITS AND APPARATUS
250/ 559. 01 .. With circuit for evaluating a web, strand, strip, or sheet
250/ 559. 19 ... Measuring dimensions

2 356/ 607 (0 OR, 2 XR)
Class 356 OPTICS: MEASURING AND TESTING
356/ 601 . SHAPE OR SURFACE CONFIGURATION
356/ 602 .. Triangulation
356/ 606 ... Line of light projected
356/ 607 Scan

2 382/ 144 (0 OR, 2 XR)
Class 382 IMAGE ANALYSIS
382/ 100 . APPLICATIONS
382/ 141 .. Manufacturing or product inspection
382/ 144 ... Mask inspection (e.g., semiconductor photomask)

2 382/ 103 (2 OR, 0 XR)
Class 382 IMAGE ANALYSIS
382/ 100 . APPLICATIONS
382/ 103 .. Target tracking or detecting

2 701/ 209 (2 OR, 0 XR)
Class 701 DATA PROCESSING: VEHICLES, NAVIGATION, AND RELATIVE LOCATION
701/ 200 . NAVIGATION
701/ 207 .. Employing position determining equipment
701/ 208 ... For use in a map data base system
701/ 209 Including route searching or determining device